Search Notes



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Applicant(s)/Patent Under Reexamination

STASZEWSKI ET AL.

Examiner

Art Unit

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2817

SEARCHED

Class	Subclass	Date	Examiner		
330	295	12/01/2006	KMF		

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Search Notes	Date	Examiner
375/295.CCLS. AND TEXT LIMITATION and Text search	12/01/2006	kmf
375/355 375/371 375/373 375/374 375/375 375/295 327/141 327/154	05/30/2008	KMF
327/155 713/400 713/401 with text limitations; text search		

INTERFERENCE SEARCH

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375	295	05/30/2008	KMF			

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